



Through Hole Lamp Product Data Sheet LTL1CHJDE

Spec No.: DS20-2013-0105

Effective Date: 05/18/2013

Revision: -

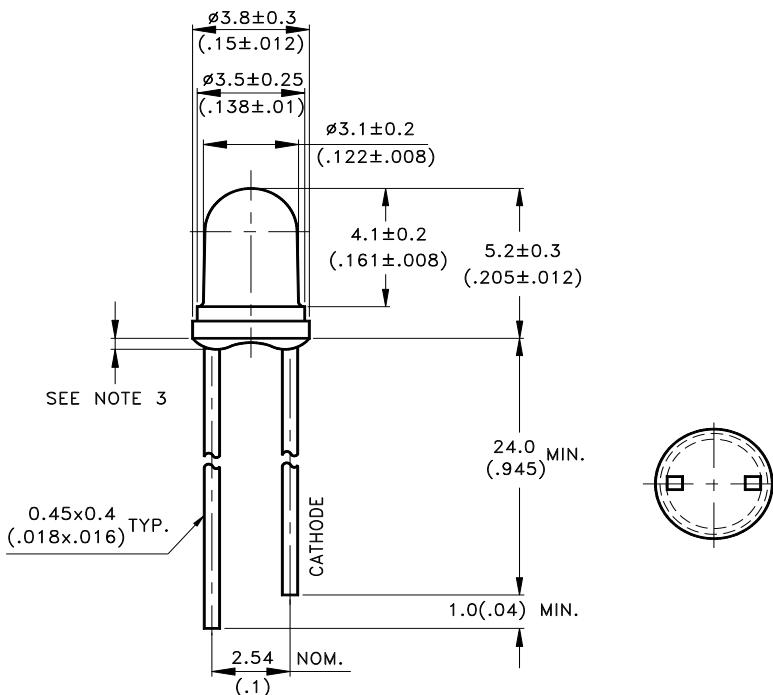
LITE-ON DCC

RELEASE

Features

- * Lead (Pb) free product – RoHS compliant.
- * High luminous intensity output.
- * Low power consumption.
- * High efficiency.
- * Versatile mounting on P.C. Board or panel.
- * I.C. Compatible/low current requirement.
- * 3.1 mm diameter package.

Package Dimensions



Part No.	Lens	Source Color
LTL1CHJDE	Red Diffused	AlInGaP Super Red

Notes:

1. All dimensions are in millimeters (inches).
2. Tolerance is ± 0.25 mm (.010") unless otherwise noted.
3. Protruded resin under flange is 1.0 mm (.04") max.
4. Lead spacing is measured where the leads emerge from the package.
5. Specifications are subject to change without notice.

Absolute Maximum Ratings at TA=25 °C

Parameter	Maximum Rating	Unit
Power Dissipation	75	mW
Peak Forward Current (1/10 Duty Cycle, 0.1ms Pulse Width)	90	mA
DC Forward Current	30	mA
Derating Linear From 50°C	0.4	mA/°C
Operating Temperature Range	-40°C to + 100°C	
Storage Temperature Range	-55°C to + 100°C	
Lead Soldering Temperature [2.0 mm(.078") From Body]	260°C for 5 Seconds Max.	

Electrical / Optical Characteristics at TA=25 °C

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Condition
Luminous Intensity	I _V	85	240	310	mcd	I _F = 20mA Note 1
Viewing Angle	2θ _{1/2}		60		deg	Note 2 (Fig.5)
Peak Emission Wavelength	λ _P		632		nm	Measurement @Peak (Fig.1)
Dominant Wavelength	λ _d	617	621	629	nm	Note 4
Spectral Line Half-Width	Δλ		20		nm	
Forward Voltage	V _F		2.0	2.4	V	I _F = 20mA
Reverse Current	I _R			100	μA	V _R = 5V

NOTE: 1. Luminous intensity is measured with a light sensor and filter combination that approximates the CIE eye-response curve.

2. θ_{1/2} is the off-axis angle at which the luminous intensity is half the axial luminous intensity.
3. I_V classification code is marked on each packing bag.
4. The dominant wavelength, λ_d is derived from the CIE chromaticity diagram and represents the single wavelength which defines the color of the device.
5. Reverse Voltage (V_R) condition is applied for IR test only. The device is not designed for reverse Operation.

Typical Electrical / Optical Characteristics Curves

(25 °C Ambient Temperature Unless Otherwise Noted)

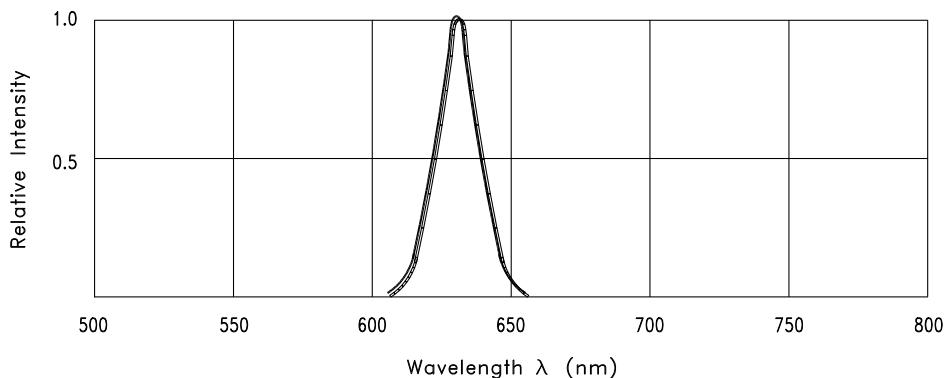


Fig.1 Relative Intensity vs. Wavelength

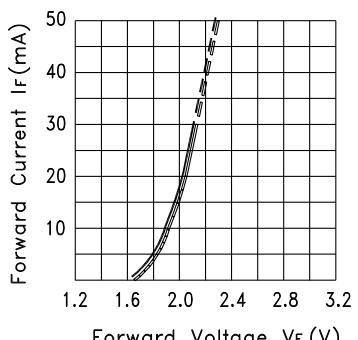


Fig.2 Forward Current vs. Forward Voltage

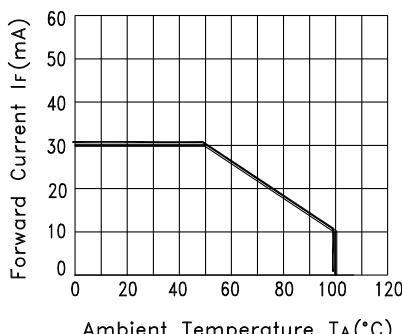


Fig.3 Forward Current Derating Curve

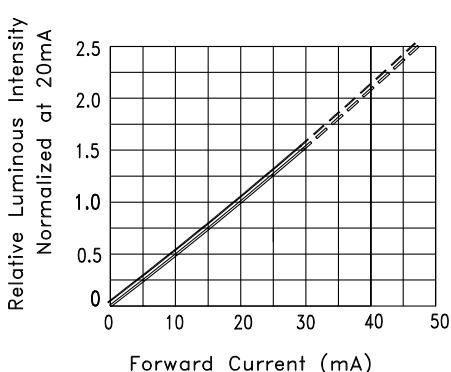


Fig.4 Relative Luminous Intensity vs. Forward Current

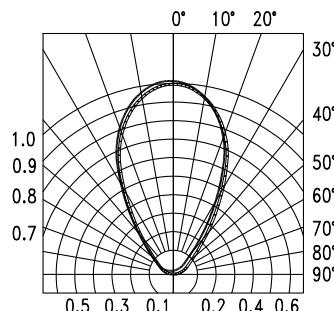
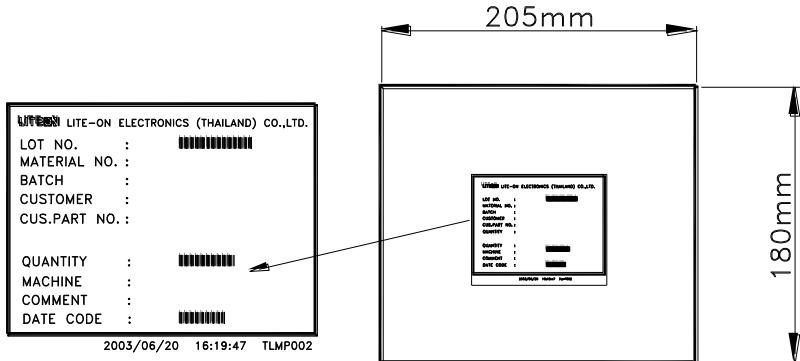


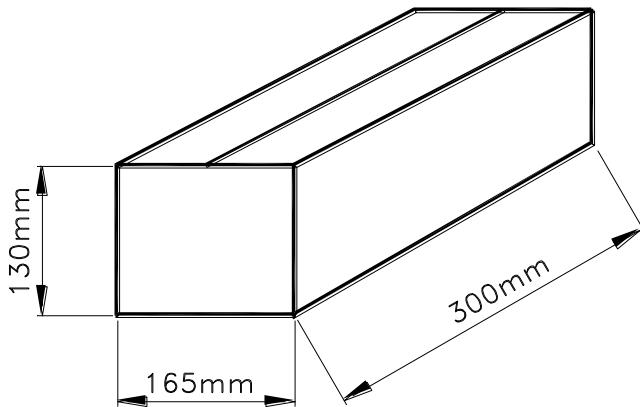
Fig.5 Spatial Distribution

Packing Spec

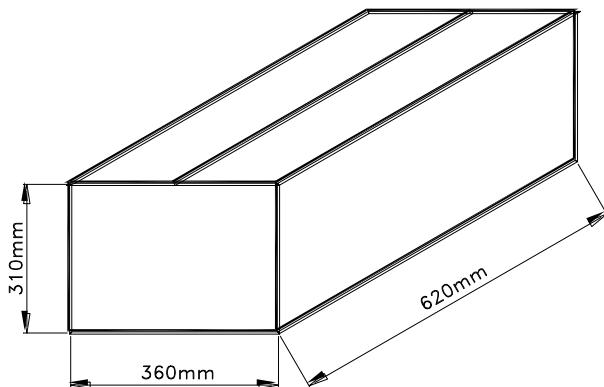
1000, 500, 200, or 100 pcs per packing bag



**10 packing bags per inner carton
total 10000 pcs per inner carton**



**8 Inner cartons per outer carton
total 80000 pcs per outer carton
In every shipping lot, only the last**



Bin Table Specification

Luminous Intensity		Unit : mcd @20mA
Bin Code	Min.	Max.
EF	85	140
GH	140	240
J	240	310

Note: Tolerance of each bin limit is $\pm 15\%$

Dominant Wavelength		Unit : nm @20mA
Bin Code	Min.	Max.
H28	617.0	621.0
H29	621.0	625.0
H30	625.0	629.0

Note: Tolerance of each bin limit is $\pm 1\text{nm}$

CAUTIONS

1. Application

The LEDs described here are intended to be used for ordinary electronic equipment (such as office equipment, communication equipment and household applications). Consult Liteon's Sales in advance for information on applications in which exceptional reliability is required, particularly when the failure or malfunction of the LEDs may directly jeopardize life or health (such as in aviation, transportation, traffic control equipment, medical and life support systems and safety devices).

2. Storage

The storage ambient for the LEDs should not exceed 30°C temperature or 70% relative humidity. It is recommended that LEDs out of their original packaging are used within three months. For extended storage out of their original packaging, it is recommended that the LEDs be stored in a sealed container with appropriate desiccant or in desiccators with nitrogen ambient.

3. Cleaning

Use alcohol-based cleaning solvents such as isopropyl alcohol to clean the LEDs if necessary.

4. Lead Forming & Assembly

During lead forming, the leads should be bent at a point at least 3mm from the base of LED lens. Do not use the base of the lead frame as a fulcrum during forming. Lead forming must be done before soldering, at normal temperature. During assembly on PCB, use minimum clinch force possible to avoid excessive mechanical stress.

5. Soldering

When soldering, For Lamp without stopper type and must be leave a minimum of 3mm clearance from the base of the lens to the soldering point. To avoided the Epoxy climb up on lead frame and was impact to non-soldering problem, Dipping the lens into the solder must be avoided.

Do not apply any external stress to the lead frame during soldering while the LED is at high temperature.

Recommended soldering conditions

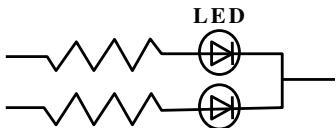
Soldering iron		Wave soldering	
Temperature Soldering time	350°C Max. 3 sec. Max. (one time only)	Pre-heat Pre-heat time Solder wave Soldering time	100°C Max. 60 sec. Max. 260°C Max. 5 sec. Max.

Note: Excessive soldering temperature and/or time might result in deformation of the LED lens or catastrophic failure of the LED. IR reflow is not suitable process for through hole type LED lamp product.

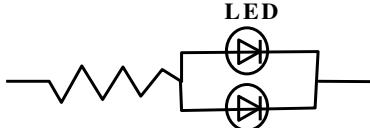
6. Drive Method

An LED is a current-operated device. In order to ensure intensity uniformity on multiple LEDs connected in parallel in an application, it is recommended that a current limiting resistor be incorporated in the drive circuit, in series with each LED as shown in Circuit A below.

Circuit model A



Circuit model B



(A) Recommended circuit

(B) The brightness of each LED might appear different due to the differences in the I-V characteristics of those LEDs

7. ESD (Electrostatic Discharge)

Static Electricity or power surge will damage the LED.

Suggestions to prevent ESD damage:

- Use a conductive wrist band or anti- electrostatic glove when handling these LEDs
- All devices, equipment, and machinery must be properly grounded
- Work tables, storage racks, etc. should be properly grounded
- Use ion blower to neutralize the static charge which might have built up on surface of the LEDs plastic lens as a result of friction between LEDs during storage and handing

ESD-damaged LEDs will exhibit abnormal characteristics such as high reverse leakage current, low forward voltage, or “no light up” at low currents. To verify for ESD damage, check for “light up” and V_f of the suspect LEDs at low currents.

The V_f of “good” LEDs should be $>2.0V@0.1mA$ for InGaN product and $>1.4V@0.1mA$ for AlInGaN product.

Chip ESD level	Machine Model	Human Body Model
InGaN / Sapphire	100 V	300 V
AlInGaN	200 V	500 V
InGaN / SiC	600 V	1000 V

Suggested checking list :**Training and Certification**

1. Everyone working in a static-safe area is ESD-certified?
2. Training records kept and re-certification dates monitored?

Static-Safe Workstation & Work Areas

1. Static-safe workstation or work-areas have ESD signs?
2. All surfaces and objects at all static-safe workstation and within 1 ft measure less than 100V?
3. All ionizer activated, positioned towards the units?
4. Each work surface mats grounding is good?

Personnel Grounding

1. Every person (including visitors) handling ESD sensitive (ESDS) items wear wrist strap, heel strap or conductive shoes with conductive flooring?
2. If conductive footwear used, conductive flooring also present where operator stand or walk?
3. Garments, hairs or anything closer than 1 ft to ESD items measure less than 100V*?
4. Every wrist strap or heel strap/conductive shoes checked daily and result recorded for all DSL?
5. All wrist strap or heel strap checkers calibration up to date?

Note: *50V for Blue LED.

Device Handling

1. Every ESDS items identified by EIA-471 labels on item or packaging?
2. All ESDS items completely inside properly closed static-shielding containers when not at static-safe workstation?
3. No static charge generators (e.g. plastics) inside shielding containers with ESDS items?
4. All flexible conductive and dissipative package materials inspected before reuse or recycle?

Others

1. Audit result reported to entity ESD control coordinator?
2. Corrective action from previous audits completed?
3. Are audit records complete and on file?

8. Reliability Test

Classification	Test Item	Test Condition	Reference Standard
Endurance Test	Operation Life (LT)	Ta = under room temperature IF = per datasheet maximum drive current *Test time = 1000 hrs	MIL-STD-750D:1026 (1995) MIL-STD-883G:1005 (2006)
	High temperature/ High humidity storage (THS)	Ta = 60°C RH = 90% Test time = 240hrs	MIL-STD-202G:103B (2002) JEITA ED-4701:100 103 (2001)
	High temperature storage	Ta = 105 ± 5 °C Test time = 1000 hrs	MIL-STD-750D:1031 (1995) MIL-STD-883G:1008 (2006) JEITA ED-4701:200 201 (2001)
	Low temperature storage	Ta= -55 ± 5 °C Test time = 1000 hrs	JEITA ED-4701: 200 202 (2001)
Environmental Test	Temperature cycling	100°C ~ 25°C ~ -40°C ~ 25°C 30 mins 5 mins 30 mins 5 mins 30 cycles	MIL-STD-750D:1051 (1995) MIL-STD-883G:1010 (2006) JEITA ED-4701:100 105 (2001) JESD22-A104C (2005)
	Thermal Shock	100 ± 5 °C ~ -30 ± 5 °C 15 mins 15 mins 30 cycles (< 20 secs transfer)	MIL-STD-750D:1056 (1995) MIL-STD-883G:1011 (2006) MIL-STD-202G:107G (2002) JESD22-A106B (2004)
	Solder resistance (no pre-condition)	T.sol = 260 ± 5°C Dwell time = 10 ± 1 sec 3mm from the base of the epoxy bueb	MIL-STD-750D:2031 (1995) JEITA ED-4701: 300 302 (2001)
	Solderability (no pre-condition)	T.sol = 245 ± 5°C Dwell time = 5 ± 0.5 sec	MIL-STD-750D:2026 (1995) MIL-STD-883G:2003 (2006) MIL-STD-202G:208H (2002) IPC/EIA J-STD-002 (2004)
	Soldering Iron (no pre-condition)	T.sol = 350 ± 5°C Dwell time = 3.5 ± 0.5 sec	MIL-STD-202G:208H (2002) JEITA ED-4701: 300 302 (2001)

9. Others

The appearance and specifications of the product may be modified for improvement, without prior notice.